

James

PSC 04

PHILIPS

Philips Semiconductors

September 1, 2004

Mr. William McDonald
New Mexico Environment Department
c/o Sandia National Laboratory
P.O. Box 5800/MS-1087
Albuquerque, NM 87185



SUBJECT: Quarterly Progress Report

Dear Mr. McDonald:

In compliance with Philips Semiconductors' HSWA permit (NMD000709782-1), modified March 18, 1996, this letter serves as the quarterly progress report as required. The following progress has been made between July 1, 2004, and September 1, 2004:

- *D.1(a) - A description of the work completed and an estimate of the percentage of work completed:* Quarterly groundwater monitoring was completed on June 17, 2004. Nine (9) monitoring wells were sampled on the Philips site and four off-site NCLF wells. The five Philips wells were MW-1, MW-2, MW4, MW-5, MW-6, and the four NCLF wells were 2, 4, 3 and 8.
- *D.1(b) - Summaries of all findings, including summaries of laboratory data:* A quarterly groundwater monitoring report is included with this report for your files. All wells were sampled only for Tetrachlorethylene (PCE). This change is in accordance with the Class I Permit Modification issued by NMED to Philips Semiconductors on January 6, 2000 that places all Philips wells on annual monitoring frequency.
- *D.1(c) - Summaries of all problems or potential problems encountered during the reporting period and actions taken to rectify problems:* No problems identified.
- *D.1(d) - Projected work for the next reporting period:* Third quarter groundwater monitoring for Tetrachlorethylene will take place in September.
- *D.1(e) - Summaries of contacts pertaining to corrective action or environmental matters with representatives of the local community, public interest groups or State government during the reporting period:* August 27th RFI review meeting with NMED.



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San Jose, CA 95131-1706

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- *D.1(f) - Changes in key project personnel during the reporting period:* No changes, Glen Tsukamoto, Environmental Manager continues to serve as the technical contact.
- *D.1(g) - Summaries of all changes made in implementation during the reporting period:* No Changes.

If you have any questions regarding this submission, please call our technical contact Glen Tsukamoto at (408) 474-6129.

I certify under penalty of law that this document and all attachments were prepared under my direction or supervision in accordance with a system designed to assure that qualified personnel properly gather and evaluate the information submitted. Based on my inquiry of the person or persons who manage the system, or those persons directly responsible for gathering the information, the information submitted is, to the best of my knowledge and belief, true, accurate, and complete. I am aware that there are significant penalties for submitting false information, including the possibility of fine and imprisonment for knowing violations.

Sincerely,



Keith Flagler
VP and General Manager, Semiconductor Shared Services

cc:

w/ enclosure:

James Harris, USEPA Region VI
Doug Earp, City of Albuquerque
Philips Semiconductors Environmental File

w/o enclosures:

Philips Legal Counsel - Sunnyvale
✓ James P. Bearzi, NMED
Baird Swanson, NMED/GWP



PHILIPS

Philips

January 26, 2004

To Whom It May Concern:

I declare Mr. Glen Tsukamoto, Environmental Manager to be an authorized representative for Philips Semiconductors on environmental permit application, permits and reports related to Philips Semiconductors, Sunnyvale, San Jose, Albuquerque, and San Antonio Sites.

A handwritten signature in cursive script, appearing to read "Keith Flagler".

Keith Flagler
Senior Vice President and General Manager

A handwritten signature in cursive script, appearing to read "Bob Hamilton".

Bob Hamilton
SEHS Manager

A handwritten signature in cursive script, appearing to read "Glen Tsukamoto".

Glen Tsukamoto
Environmental Safety Manager



ASSAIGAI ANALYTICAL LABORATORIES, INC.

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127 Eastgate Drive, 212-C • Los Alamos, New Mexico 87544 • (505) 662-2558

July 10, 2004

Mr. Bob Sanders
Philips Semiconductors, Inc.
9201 Pan American Highway NE
Albuquerque, NM 87113

Re: June 2004 Groundwater Monitoring Results Philips Semiconductors Albuquerque Facility

Dear Bob,

The following information outlines the events as they took place by **Sangre De Cristo Sciences, LLC**. On June 17, 2004 representatives from **Sangre De Cristo Sciences, LLC (SDCS, LLC)** performed the quarterly monitoring of 9 groundwater wells on **Philips Semiconductors** site and on off site NCLF city wells. Five wells at the Philips site, MW-1, MW-2, MW-4, MW-5 & MW-6, and four wells at the former Nazareth Colorado Landfill (NCLF- 2, 4, 3 & 8) were measured for groundwater levels, purged and sampled pursuant to the protocol as listed in the statement of work provided by **Philips Semiconductors and analyzed for Tetrachloroethylene only**.

Mr. Scott Pratt and Mr. Elvin J. Chavez of **SDCS, LLC** conducted the groundwater monitoring in accordance with the scope of work. All wells were sampled with a stainless steel Grundfos Rediflo 2 pump, reel and PTFE tubing. *Field notes are included as Attachment 1.*

Methods

The groundwater levels were checked in all 9 monitor wells, measured from the top of each well casing and total well depths were used to calculate the required 3 well volumes for purging. Measurements for the previous event, April 2004, and the current June are illustrated in Table 1. Water levels were slightly different than those taken in April possibly due to limited precipitation and drought conditions.

Throughout the sampling event and purging of all 9 wells, **SDCS, LLC** personnel monitored water quality parameters (pH, conductivity and temperature) and recorded all results in field activity logbooks provided by **Philip Semiconductors**.

The nine wells were purged and sampled using a Grundfos Rediflo 2 stainless steel pump, reel and tubing, which has been dedicated to this project only. Three well casing volumes were purged and water quality parameters were allowed to stabilize prior to collecting groundwater samples for analysis.

All samples were collected in appropriate containers provided by **Assagai Analytical Laboratories, Inc. (AALI)** of Albuquerque, NM. Samples were labeled, filled and stored in a cooler, on ice and delivered to newly constructed **AALI** laboratory at 4301 Masthead NE, with the required chain of custody.

Laboratory Analysis

The groundwater samples were analyzed for PCE only by USEPA 524.2. All laboratory analytical results, chain of custody forms and QA/QC reports are supplied as **Attachment 2**.

Data Quality Assessment

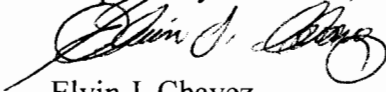
SDCS, LLC has reviewed the analytical reports for compliance with data quality objectives, holding times, method requirements, surrogate recoveries, MS & MSD recoveries and their associated RPD. All parameters were performed in strict accordance within holding times and USEPA method requirements and were found to meet all criteria. Trace concentrations of Volatile Organic Compounds (VOC) were detected in the samples, but were well below Maximum Contaminant Levels (MCL) as listed in the tables provided by **Philips Semiconductors**.

Laboratory Results and QA/QC Report

The analytes detected during the April 2004 quarterly groundwater-monitoring event are listed in Table 2 along with MCL's. The VOC of concern detected was Tetrachloroethylene, (PCE). The attached QA/QC report shows all associated QC including method blanks, Laboratory Control Sample (LCS & LCSD), Matrix Spikes (MS & MSD) and all supporting statistical data.

Sangre De Cristo Sciences, LLC appreciates the opportunity to work for you and **Philips Semiconductors** and looks forward to continued business with you. If you should have any questions or comments regarding this report or event, please feel free to contact me at (505) 259-9795.

Respectfully submitted,



Elvin J. Chavez

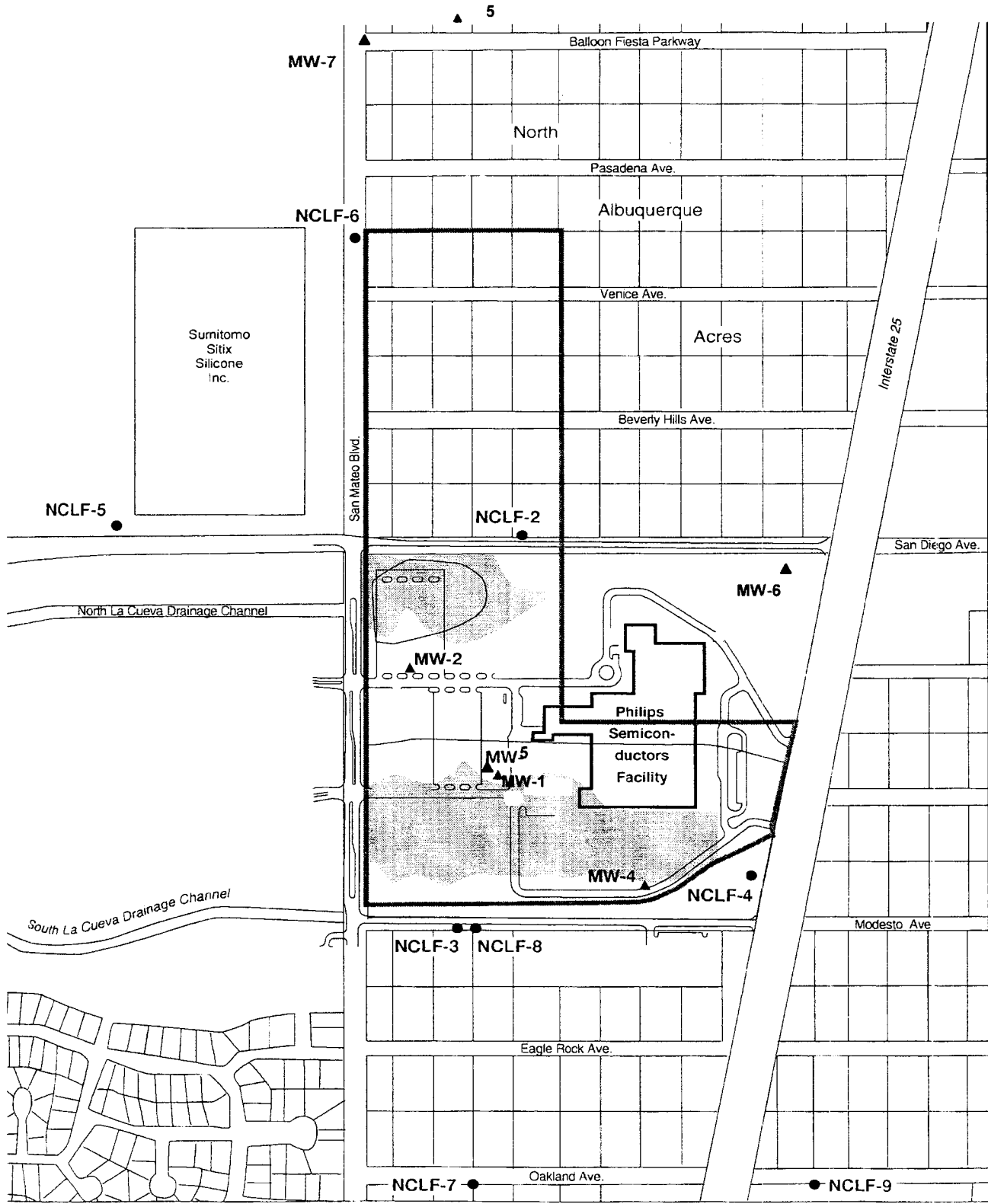
President

Sangre De Cristo Sciences, LLC

Figure 1 – Site Map

Philips Semiconductors
2002 Groundwater Monitoring - Scope of Work

12. Figures
12.1 Site Map



Tables 1 & 2

June 2004 Groundwater Depths and Detected Analytes

**Table 1. Depth to Groundwater in Philips Semiconductor Monitor
Wells for June 2004 events**

Monitor Well #	June 2004 Levels	April 2004 Levels
MW-5	218.75	218.6
MW-6	238.87	239.65
NCLF-3	207.68	207.6
NCLF-8	208.86	208.7
NCLF-4	246.9	246.7
MW-1	212.37	211.2
MW-4	228.07	228.0
MW-2	199.77	199.7
NCLF-2	201.98	201.9

**Table 2. Detected Analytes in Philips
Semiconductor Monitor Wells for June 2004**

	MW 5	MW 1	MW 6	NCLF 2	NCLF 8	NCLF 4	NCLF 3	MW 4	MW 2	MCL*
Tetrachloroethylene (PCE), ppb	<0.5	4.4	<0.5	5.9	2.7	5.5	5.8	4.7	6.3	5.0 ug/L (ppb)

Bold items Denote Analytes over MCL

Attachment 1 - Field Activity Notes

June 17, 2004 Elvin Chaur / Scott Pratt

Time	Cond	Temp	pH	vol.	4" casing
MW-5	D.T.W. 218.75	T.D. 316.4			
Water column 98.65 190gal. purge clear - breezy					
800	701	17.1	7.5	1st	
815	704	16.9	7.6	40 gal.	
833	695	17.0	7.7	80 "	
855	693	17.1	7.5	100 "	
917	693	17.2	7.5	140 "	
935	694	17.1	7.6	190 "	
Sampled @ 938 for Tetrachloroethylene only					
2-40ml vial w/ HPLC					

MW-1 D.T.W. 212.37 T.D. 217.52 2" casing
 water column 35.15 purge vol. 71.5 gal.

Time	Cond	Temp	pH	vol.
955	419	24.1	7.35	1st
1000	417	23.9	7.31	10
1005	420	23.2	7.29	15
1010	419	23.7	7.30	25
1015	420	23.7	7.30	30

sampled @ 1012
 NCLF-8 D.T.W. 208.86 T.D. 206.5 4" casing
 water column 57.64 purge vol. 113 gal.

Time	Cond	Temp	pH	vol.
1028	7147	17.9	7.50	1st
1033	7145	18.0	7.49	25 gal.
1040	7144	18.1	7.47	50
1045	7143	18.0	7.47	75
1050	7143	18.1	7.47	110

June 17, 2004

Time	Cond	Temp	pH	vol.
NCLF-3	D.T.W. 207.48	T.D. 201.7		
Water column - 11 87 gal. purge				
1115	720	15.9	7.09	1st
1125	718	16.0	7.10	10 gal.
1135	720	15.8	7.11	20 gal.
1145	721	15.9	7.11	27 gal.

sampled @ 1117
 NCLF-4 D.T.W. 214.9 T.D. 205.38
 water column 18.42 36 gal. purge

Time	Cond	Temp	pH	vol.
1205	1500	12.0	6.9	1st
1210	1505	16.5	7.1	5
1220	1433	16.8	7.0	10
1230	1420	17.4	7.1	20
1239	1421	17.1	7.0	35

sampled @ 1258
 NCLF-2 D.T.W. 201.98 T.D. 203.25
 water column 21.87 purge vol. 42

Time	Cond	Temp	pH	vol.
1313	595	16.2	7.6	1st
1323	625	16.0	7.5	20 gal.
1335	628	15.8	7.4	30
1347	625	15.8	7.4	40

sampled @ 1349

June 17, 2004

MW-6	D.T.W.	239.87	T.D.	263.75	4" casing
Water column		24.88	Purge vol. 49		
Time	Cond	Temp	pH	Vol.	
1358	400	18.9	7.44	1st	
1405	390	18.4	7.40	20	
1420	385	19.5	7.39	30	
1430	388	19.4	7.39	40	

sampled @ 1431

MW-4	D.T.W.	228.07	T.D.	240.0	2" casing
Water column		11.9	Purge vol. 6 gal.		
Time	Cond.	Temp.	pH	Vol.	
1530	850	25.0	6.75	1st	
1540	820	21.0	6.70	1 gal.	
1550	815	20.1	6.69	2 "	
1600	814	20.1	6.65	3 "	
1610	815	20.0	6.65	6 "	

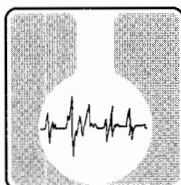
sampled @ 1612

MW-2	D.T.W.	199.77	T.D.	226.67	2" casing
Water column		26.9	Purge vol. 13		
Time	Cond	Temp.	pH	Vol.	
1638	620	15.8	7.41	1st	
1645	625	15.7	7.25	2	
1655	625	15.7	7.24	5	
1700	628	15.8	7.30	8	
1710	627	15.7	7.28	12	

sampled @ 1717

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Attachment 2 – Laboratory Report – QA/QC Report



ASSAIGAI ANALYTICAL LABORATORIES, INC.

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Explanation of codes

B	analyte detected in Method Blank
E	result is estimated
H	analyzed out of hold time
N	tentatively identified compound
S	subcontracted
1-9	see footnote

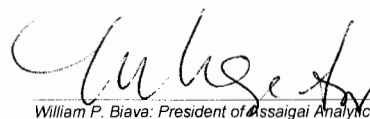
PHILIPS SEMICONDUCTORS
attn: **JOE MAUSER**
9201 PAN AMERICAN FRWY NE
ALBUQUERQUE NM 87113

STANDARD

Assaigai Analytical Laboratories, Inc.

Certificate of Analysis

Client: **PHILIPS SEMICONDUCTORS**
Project: **MW'S- JUNE 04**
Order: **0406411 PHI16** Receipt: **06-17-04**



William P. Biava: President of Assaigai Analytical Laboratories, Inc.

Sample: **MW- #5** Collected: **06-17-04 9:38:00** By: **SP**
Matrix: **GW**

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date
EPA 524.2 rev 4 Purgeable VOCs by GC/MS By: C/CWJ										
X04771	XG.2004.1149.8	127-18-4	Tetrachloroethylene	ND	ug / L	25	0.5		07-02-04	07-02-04

Sample: **MW- #1** Collected: **06-17-04 10:17:00** By: **SP**
Matrix: **GW**

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date
EPA 524.2 rev 4 Purgeable VOCs by GC/MS By: C/CWJ										
X04763	XG.2004.1142.8	127-18-4	Tetrachloroethylene	4.4	ug / L	1	0.5		07-01-04	07-01-04

Sample: **NCLF-8** Collected: **06-17-04 10:53:00** By: **SP**
Matrix: **GW**

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date
EPA 524.2 rev 4 Purgeable VOCs by GC/MS By: C/CWJ										
X04763	XG.2004.1142.9	127-18-4	Tetrachloroethylene	2.7	ug / L	1	0.5		07-01-04	07-01-04

Assagai Analytical Laboratories, Inc.

Certificate of Analysis

Client: PHILIPS SEMICONDUCTORS

Project: MW'S- JUNE 04

Order: 0406411 PHI16 Receipt: 06-17-04

Sample: NCLF-3 Collected: 06-17-04 11:47:00 By: SP

Matrix: GW

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date	
0406411-04A			EPA 524.2 rev 4 Purgeable VOCs by GC/MS					By: C/CWJ			
X04763	XG.2004.1142.10	127-18-4	Tetrachloroethylene	5.8	ug / L	1	0.5		07-01-04	07-01-04	

Sample: NCLF-4 Collected: 06-17-04 12:58:00 By: SP

Matrix: GW

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date	
0406411-05A			EPA 524.2 rev 4 Purgeable VOCs by GC/MS					By: C/CWJ			
X04763	XG.2004.1142.11	127-18-4	Tetrachloroethylene	5.5	ug / L	1	0.5		07-01-04	07-01-04	

Sample: NCLF-2 Collected: 06-17-04 13:49:00 By: SP

Matrix: GW

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date	
0406411-06A			EPA 524.2 rev 4 Purgeable VOCs by GC/MS					By: C/CWJ			
X04763	XG.2004.1142.12	127-18-4	Tetrachloroethylene	5.9	ug / L	1	0.5		07-01-04	07-01-04	

Sample: MW- #6 Collected: 06-17-04 14:31:00 By: SP

Matrix: GW

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date	
0406411-07A			EPA 524.2 rev 4 Purgeable VOCs by GC/MS					By: C/CWJ			
X04763	XG.2004.1142.13	127-18-4	Tetrachloroethylene	ND	ug / L	1	0.5		07-01-04	07-01-04	

Sample: MW- #4 Collected: 06-17-04 16:12:00 By: SP

Matrix: GW

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date	
0406411-08A			EPA 524.2 rev 4 Purgeable VOCs by GC/MS					By: C/CWJ			
X04763	XG.2004.1142.14	127-18-4	Tetrachloroethylene	4.7	ug / L	1	0.5		07-01-04	07-01-04	

Assagai Analytical Laboratories, Inc.
Certificate of Analysis

Client: **PHILIPS SEMICONDUCTORS**
Project: **MW'S- JUNE 04**
Order: **0406411 PHI16** Receipt: **06-17-04**

Sample: **MW- #2** Collected: **06-17-04 17:17:00** By: **SP**
Matrix: **GW**

QC Group	Run Sequence	CAS #	Analyte	Result	Units	Dilution Factor	Detection Limit	Code	Prep Date	Run Date
0406411-09A			EPA 524.2 rev 4 Purgeable VOCs by GC/MS					By: C/CWJ		
X04763	XG.2004.1142.15	127-18-4	Tetrachloroethylene	6.3	ug / L	1	0.5		07-01-04	07-01-04

Unless otherwise noted, all samples were received in acceptable condition and all sampling was performed by client or client representative. Sample result of ND indicates Not Detected, ie result is less than the sample specific Detection Limit. Sample specific Detection Limit is determined by multiplying the sample Dilution Factor by the listed Reporting Detection Limit. All results relate only to the items tested. Any miscellaneous workorder information or footnotes will appear below.

Assagai Analytical Laboratories, Inc.

Quality Control Summary

Client: **PHILIPS SEMICONDUCTORS**
 Project: **MW'S- JUNE 04**
 Order: **0406411 PHI16**

Explanation of codes

D Not applicable due to sample dilution
 L Not applicable due to MDL proximity

Type: **LCS: Lab Control Spike** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Run Code	Run Date	
		EPA 524.2 rev 4 Purgeable VOCs by GC/MS						X04763-014		
XG.2004.1142.5	127-18-4	Tetrachloroethylene	92	% Recovery	70 - 130	1	NA		07-01-04	
		EPA 524.2 rev 4 Purgeable VOCs by GC/MS						X04771-002		
XG.2004.1149.7	127-18-4	Tetrachloroethylene	122	% Recovery	70 - 130	1	NA		07-02-04	

Type: **MB: Method Blank** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Run Code	Run Date	
		EPA 524.2 rev 4 Purgeable VOCs by GC/MS						X04763-001		
XG.2004.1142.6	127-18-4	Tetrachloroethylene	ND	ug / L		1	0.5		07-01-04	
		EPA 524.2 rev 4 Purgeable VOCs by GC/MS						X04771-001		
XG.2004.1149.6	127-18-4	Tetrachloroethylene	ND	ug / L		1	0.5		07-02-04	

Assagai Analytical Laboratories, Inc.

QC Surrogate SummaryClient: **PHILIPS SEMICONDUCTORS**Project: **MW'S- JUNE 04**Order: **0406411 PHI16****Explanation of codes**

D	Not applicable due to sample dilution
L	Not applicable due to MDL proximity

Sample: **0406411-01A** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Code	Run Date
X04771	524							X04771-003	
XG.2004.1149.8		1,2-Dichlorobenzene-d4 (SS)	107	% Recovery	76 - 114	25	NA		07-02-04
XG.2004.1149.8		Bromofluorobenzene (SS)	106	% Recovery	75 - 125	25	NA		07-02-04

Sample: **0406411-02A** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Code	Run Date
X04763	524							X04763-003	
XG.2004.1142.8		1,2-Dichlorobenzene-d4 (SS)	115	% Recovery	76 - 114	1	NA		07-01-04
XG.2004.1142.8		Bromofluorobenzene (SS)	115	% Recovery	75 - 125	1	NA		07-01-04

Sample: **0406411-03A** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Code	Run Date
X04763	524							X04763-004	
XG.2004.1142.9		1,2-Dichlorobenzene-d4 (SS)	109	% Recovery	76 - 114	1	NA		07-01-04
XG.2004.1142.9		Bromofluorobenzene (SS)	108	% Recovery	75 - 125	1	NA		07-01-04

Sample: **0406411-04A** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Code	Run Date
X04763	524							X04763-005	
XG.2004.1142.10		1,2-Dichlorobenzene-d4 (SS)	111	% Recovery	76 - 114	1	NA		07-01-04
XG.2004.1142.10		Bromofluorobenzene (SS)	111	% Recovery	75 - 125	1	NA		07-01-04

Sample: **0406411-05A** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Code	Run Date
X04763	524							X04763-006	
XG.2004.1142.11		1,2-Dichlorobenzene-d4 (SS)	112	% Recovery	76 - 114	1	NA		07-01-04
XG.2004.1142.11		Bromofluorobenzene (SS)	109	% Recovery	75 - 125	1	NA		07-01-04

Sample: **0406411-06A** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Code	Run Date
X04763	524							X04763-007	
XG.2004.1142.12		1,2-Dichlorobenzene-d4 (SS)	112	% Recovery	76 - 114	1	NA		07-01-04

Assagai Analytical Laboratories, Inc.
QC Surrogate Summary

Client: **PHILIPS SEMICONDUCTORS**
Project: **MW'S- JUNE 04**
Order: **0406411 PHI16**

Explanation of codes	
D	Not applicable due to sample dilution
L	Not applicable due to MDL proximity

Sample: **MB** Matrix: **WATER**

Run Sequence	CAS #	Analyte	Result	Units	Range	Dilution Factor	Detection Limit	Code	Run Date
X04763		524		X04763-001					
XG.2004.1142.6		1,2-Dichlorobenzene-d4 (SS)	117	% Recovery	76 - 114	1	NA		07-01-04
XG.2004.1142.6		Bromofluorobenzene (SS)	109	% Recovery	75 - 125	1	NA		07-01-04
X04771		524		X04771-001					
XG.2004.1149.6		1,2-Dichlorobenzene-d4 (SS)	106	% Recovery	76 - 114	1	NA		07-02-04
XG.2004.1149.6		Bromofluorobenzene (SS)	109	% Recovery	75 - 125	1	NA		07-02-04

**ANALYTICAL
LABORATORIES, INC.**

CChain of Custody Record

4301 Masthead N.E.
ALBUQUERQUE, NEW MEXICO 87109
(505) 345-8964

3332 WEDGEWOOD
EL PASO, TEXAS 79925
(915) 593-6000

127 EASTGATE DRIVE, 212-C
LOS ALAMOS, NEW MEXICO 87544
(505) 662-2558

Lab Job No. 0406411 Date 17 JUNE 04

Page 1 of 1

Client Philips Semiconductor

Project Manager / Contact JOE MAUSER

Address _____

Telephone No. 822-7634

City / State / Zip _____

Fax No. 822-7197

Project Name / Number MW's - JUNE 04

Samplers: (signature) Scott Pratt

Contract / Purchase Order / Quote _____

No. of Containers 524.2 (PCE) only	Analysis Required										Remarks

AALI Fraction Number	Field Sample Number / Location	Date	Time	Sample Type	Type / Size of Container	Preservation												
						Temp.	Chemical											
<u>OIA</u>	<u>MW-#5</u>	<u>7/17/04</u>	<u>0938</u>	<u>GW</u>	<u>40 ML. VIAL</u>	<u>4°C</u>	<u>HCL</u>	<u>2</u>	<u>X</u>									<u>DTW - 218.75'</u>
<u>OIA</u>	<u>MW-#1</u>		<u>1017</u>					<u>2</u>	<u>X</u>									<u>212.37</u>
<u>OIA</u>	<u>NCLF-8</u>		<u>1053</u>					<u>2</u>	<u>X</u>									<u>208.86</u>
<u>OIA</u>	<u>NCLF-3</u>		<u>1147</u>					<u>2</u>	<u>X</u>									<u>207.68</u>
<u>OIA</u>	<u>NCLF-4</u>		<u>1258</u>					<u>2</u>	<u>X</u>									<u>246.9</u>
<u>OIA</u>	<u>NCLF-2</u>		<u>1349</u>					<u>2</u>	<u>X</u>									<u>201.98</u>
<u>OIA</u>	<u>MW-#6</u>		<u>1431</u>					<u>2</u>	<u>X</u>									<u>238.87</u>
<u>OIA</u>	<u>MW-#4</u>		<u>1612</u>					<u>2</u>	<u>X</u>									<u>228.07</u>
<u>OIA</u>	<u>MW-#2</u>		<u>1717</u>					<u>2</u>	<u>X</u>									<u>199.77</u>

Relinquished by: Signature <u>Scott Pratt</u> Printed <u>SCOTT PRATT</u> Company <u>AAL</u> Reason _____	Date <u>17 JUNE 04</u> Time <u>1730</u>	Received by: Signature <u>[Signature]</u> Printed <u>[Signature]</u> Company <u>[Signature]</u> Reason <u>analysis</u>	Relinquished by: Signature _____ Printed _____ Company _____ Reason _____	Date _____ Time _____	Received by: Signature _____ Printed _____ Company _____ Reason _____
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Method of Shipment _____ Shipment No. _____ Special Instructions: _____	Comments: <u>PER SCOTT SAMPLES WERE TAKEN @ 1717/04</u>	After analysis, samples are to be: <input type="checkbox"/> Disposed of (additional fee) <input type="checkbox"/> Stored (30 days max) <input type="checkbox"/> Stored over 30 days (additional fee) <input type="checkbox"/> Returned to customer
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